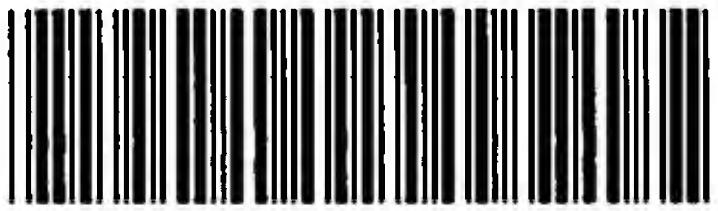


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10698976	MAULIK ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Lee, Siu M	2611	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	257, 258, 222, 357, 358, 216, 278, 279	1/19/2007	Siu M. Lee
327	65, 562, 63, 108-112, 560-563	1/19/2007	Siu M. Lee

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	1/18/2007	Siu M. Lee
Discuss the application with Chieh Fan	1/18/2007	Siu M. Lee
EAST	8/14/2007	Siu M. Lee
Discuss teh application with Chieh Fan	8/14/2007	Siu M. Lee

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>